



SPECIFICATION

• Supplier : Samsung electro-mechanics • Samsung P/N : CL21B225KAFNNNE

Product : Multi-layer Ceramic Capacitor
 Description : CAP, 2.2μF, 25V, ±10%, X7R, 0805

A. Samsung Part Number

<u>CL</u> <u>21</u> <u>B</u> <u>225</u> <u>K</u> <u>A</u> <u>F</u> <u>N</u> <u>N</u> <u>N</u> <u>E</u> ① ② ③ ④ ⑤ ⑥ ⑦ ⑧ ⑨ ⑩ ⑪

① Series	Samsung	Samsung Multi-layer Ceramic Capacitor							
② Size	0805 ((inch code)	L: 2.0	± 0.1	mm	W:	1.25	± 0.1	mm
3 Dielecti	ric X7R		8	Inner ele	ectrode		Ni		
4 Capacit	ance 2.2 ,	μF		Termina	tion		Cu		
⑤ Capacit	ance ±10 °	%		Plating			Sn 100	0%	(Pb Free)
toleran	ce		9	Product			Norma	al	
6 Rated V	oltage 25 \	V	10	Special			Reserv	ved for	future use
7 Thickne	ess 1.25 :	± 0.1 mm	11	Packagi	ng		Embos	ssed Ty	/pe, 7" reel

B. Samsung Reliablility Test and Judgement condition

	Performance	Test condition				
Capacitance	Within specified tolerance	1klb±10% 1.0±0.2Vrms				
Tan δ (DF)	0.1 max.					
Insulation	10,000Mohm or 100Mohm⋅ <i>μ</i> F	Rated Voltage 60~120 sec.				
Resistance	Whichever is Smaller					
Appearance	No abnormal exterior appearance	Microscope (×10)				
Withstanding	No dielectric breakdown or	250% of the rated voltage				
Voltage	mechanical breakdown					
Temperature	X7R					
Characterisitcs	isitcs (From -55 ℃ to 125 ℃, Capacitance change shoud be within ±15%)					
Adhesive Strength	No peeling shall be occur on the	500g·F, for 10±1 sec.				
of Termination	terminal electrode					
Bending Strength	Capacitance change : within ±12.5%	Bending to the limit (1mm)				
		with 1.0mm/sec.				
Solderability	More than 75% of terminal surface	SnAg3.0Cu0.5 solder				
	is to be soldered newly	245±5℃, 3±0.3sec.				
		(preheating : 80~120 ℃ for 10~30sec.)				
Resistance to	Capacitance change : within ±7.5%	Solder pot : 270±5℃, 10±1sec.				
Soldering heat	Tan δ, IR : initial spec.					

	Performance	Test condition				
Vibration Test	Capacitance change : within ±5%	Amplitude : 1.5mm				
	Tan δ, IR : initial spec.	From 10Hz to 55Hz (return : 1min.)				
		2hours × 3 direction (x, y, z)				
Moisture	Capacitance change : within ±12.5%	With rated voltage				
Resistance	Tan δ : 0.125 max	40±2℃, 90~95%RH, 500+12/-0hrs				
	IR : 12.5MΩ·μF or Over					
High Temperature	Capacitance change : within ±12.5%	With 150% of the rated voltage				
Resistance	Tan δ : 0.125 max	Max. operating temperature				
	IR : 25MΩ·μF or Over					
		1000+48/-0hrs				
Temperature	Capacitance change : within ±7.5%	1 cycle condition				
Cycling	Tan δ, IR : initial spec.	Min. operating temperatur → 25 ℃				
		$ ightarrow$ Max. operating temperature $ ightarrow$ 25 $^{\circ}$ C				
		5 cycle test				

C. Recommended Soldering method :

Reflow (Reflow Peak Temperature : 260+0/-5 $^{\circ}$ C , 10sec. Max)

^{*} For the more detail Specification, Please refer to the Samsung MLCC catalogue.